A High-Energy Ball Milling as a Useful Technique for the Synthesis of CaCu$_3$Ti$_4$O$_{12}$ Electroceramics

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This paper shows that CaCu$_3$Ti$_4$O$_{12}$ (CCTO) can be synthesized through the high-energy ball milling of CaO, CuO and TiO$_2$ powders. The dielectric characterization of CCTO obtained mechanically as well as, for comparison, by a high-temperature method is presented. Moreover, it is illustrated that zirconium oxide in contrast to a metallic iron generated during milling processes improves the properties of CCTO in terms of ceramic capacitors.

DOI: 10.12693/APhysPolA.126.931
PACS: 77.22.Gm, 81.05.t

1. Introduction

Ceramic materials characterized by a high value of dielectric permittivity ($\varepsilon'$) and low dielectric loss (tan $\delta$) are desirable because of their numerous possibilities for use in electronics. Currently the used materials are mainly ferroelectrics based on barium and lead oxides. Their high dielectric permittivity is associated with a structural phase transition occurring in a narrow temperature range, which limits their use in electronic devices, e.g. as capacitors. In addition, applying the mentioned toxic compounds is incompatible with the principles of green chemistry.

According to the study provided by Ramirez et al. [1], a CaCu$_3$Ti$_4$O$_{12}$ (CCTO) compound, with a perovskite structure, has the peculiar dielectric properties, i.e. a high dielectric permittivity ($\varepsilon'$) (up to $10^5$), which is practically independent of frequency (from dc to $10^6$ Hz) and temperature (between 100–600 K). However, the high value of the dielectric loss (tan $\delta$) of CCTO limits its applicability as a capacitor material [2, 3].

There are many descriptions of the mentioned above dielectric properties. At present a barrier mechanism [3, 4] is commonly accepted as the correct one. However, the nature of those barriers that lead to the colossal dielectric permittivity in CCTO is still questionable. Certain experimental results e.g. Li et al. [5], Sinclair et al. [6] indicate that the colossal dielectric permittivity is caused by the presence of internal barrier layer capacitors (IBLC), whilst others suggest surface barrier layer capacitors (SBLC) [7]. The former could stem from grain boundaries in ceramic samples and/or from boundaries between twins or other planar defects within single crystals or the crystallites of the ceramic samples. The latter could be formed by the depletion of the layers of...
and organometallic reagents that are not only expensive, but also environmentally hazardous. There are also known other CCTO ceramics synthesis techniques such as controlled co-precipitation [23], precursor solution [26] and hydrothermal [27] methods. However, many of these methods enable to synthesize CCTO with fine crystals. Nevertheless, they are unpopular, because their complexities and costs preclude their use in a large-scale industrial fabrication.

In consequence, there is considerable interest in alternative synthesis techniques that can eliminate the difficulties mentioned above. A solid-state high-energy milling process [28] offers simplicity because of one-step operation, solvent-free synthesis and/or the modification of properties of the advanced products, which can activate substrates or even drive a reaction to completion at room temperature, dependent on the chemical and physical nature of the substrates. Some of the completed reactions can result in new products, as is seen in the case of perovskites, for example see [29-31]. Thus, Amelida et al. [32], Manik and Pradhan [33] and Alizadeh et al. [34] presented the mechanochemical syntheses of nanocrystalline CCTO using the different type of CaO, CuO and TiO$_2$ powder reagents. Unfortunately, in these three papers there are not the results of the dielectric properties of synthesized CCTO as well as the information on the influence of any impurities from a reaction vessel and balls introduced into the materials. The following article attempts to fill this gap. Recently our preliminary studies have been presented in the paper [35].

This paper is aimed to explain the advantages of the mechanochemical synthesis of polycrystalline CCTO with useful dielectric properties. Additionally, the results are compared to the CCTO ceramics that was obtained with the use of a traditional high-temperature method.

2. Experimental

2.1. Chemicals

The materials used were oxides (pure p.a. 98%) of calcium (POCh), copper (II) (Fluka Analytical), titanium (Evonik Degussa GmbH). Zirconium oxide and metallic iron from the balls and vessel were considered as a factor that could affect the chemical structure of CCTO.

2.2. Synthesis procedure

2.2.1. Preparation of CaCu$_3$Ti$_4$O$_{12}$ ceramics via a high-energy ball milling technique (samples CCTO/Fe and CCTO/Zr) The CaO, CuO and TiO$_2$ powders were hand-mixed in a stoichiometric ratio in an agate mortar for 2 h. Such a mixture was subjected to mechanochemical treatment in a Pulverisette 6 (Fritsch GmbH, Germany) planetary ball mill. The reactor (250 ml) and balls of 10 mm in diameter of steel and zirconia were used, respectively.

Milling parameters: rpm = 550; ball to powder mass ratio: BPR = 20 : 1; milling time: 3 h.

2.2.2. Preparation of CaCu$_3$Ti$_4$O$_{12}$ ceramics by a high-temperature solid-state reaction (sample CCTO/T) In this case the CaO, CuO and TiO$_2$ powders were also mixed together in a stoichiometric ratio in an agate mortar for 2 h and pressed at 20 MPa into pellet discs 4 mm thick and of 12 mm in diameter. These discs were sintered in air with the use of a Nabertherm HTC 03/15 laboratory furnace for 12 h at the temperature of 1220, 1320, and 1370 K.

2.3. Measurements’ techniques

X-ray powder diffraction measurements for a phase analysis were performed on a XPert Phillips diffractometer using a Cu K$_\alpha$ radiation ($\lambda = 1.54178$ Å) between 10° < 2θ < 90° with step-width of 0.01°. JCPDF cards were used to identify the phases present in the samples.

The SEM images of the microstructure, morphology and elemental composition of obtained ceramics were taken with a HITACHI S-4700 instrument with X-ray EDS analysis.

The elemental compositions of the bulk samples were measured by an energy-dispersive X-ray fluorescence spectroscopy (XRF) using a XRF Bruker S4 Explorer instrument.

The dielectric spectroscopy measurements in the frequency domain were performed at frequency ranging from 20 Hz to 1 MHz with the use of a LCR Agilent 4284A meter and a Quatro Krio 40 temperature control system. The dielectric property measurements were carried out at temperature between 473 ± 173 K with a 5 K step. To perform the dielectric measurements the samples of 7 mm in diameter and 2.5 mm thick were covered with silver electrodes.

3. Results and discussion

3.1. Characteristics of CCTO ceramics synthesized by two different methods

The XRD pattern of the CCTO powder obtained mechanochemically is shown in Fig. 1. Regardless whether the reaction vessel and balls were made of zirconia (CCTO/Zr) or iron (CCTO/Fe), CaCu$_3$Ti$_4$O$_{12}$ was identified in accordance with the JCPDS PDF No. 75-2188. The XRF elemental analyses show that the impurities from milling process are present in amount of 1.5 wt.% ZrO$_2$ and 2.2 wt.% Fe in CCTO/Zr and CCTO/Fe, respectively (this is not detectable in the XRD patterns).

In Fig. 2 the X-ray powder pattern of CCTO obtained, for comparison, via the high-temperature synthesis (CCTO/T) is shown.

The CCTO samples synthesized by mechanical treatment show the lower intensities of peaks and they are wider than those of the material obtained through the high-temperature synthesis. This indicates that the mechanochemically-obtained crystals are much smaller and display a higher defected structure. Moreover, it was stated that the sample was partially amorphous and heating for 1 h at the temperature of 1270 K improves the crystallinity of CCTO, and so the amorphous phase disappears.
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Fig. 1. XRD pattern of CaCu$_3$Ti$_4$O$_{12}$ (CCTO/Zr) sample mechanochemically synthesized using vial and balls with zirconia.

Fig. 2. XRD pattern of CaCu$_3$Ti$_4$O$_{12}$ (CCTO/T) sample synthesized by high-temperature treatment.

3.2. Morphological observations of different CCTO samples

The morphological differences between the particles obtained by above mentioned two methods are illustrated in SEM photomicrographs in Fig. 3. The CCTO/T ceramics have the largest particle sizes (ranging between 1.5 and 2.5 µm) of any of the studied samples. Sinters are also visible in the material. Smaller crystals are present along the edges of the particles that are caused probably by a liquid phase of CuO that forms under high temperature conditions and recrystallizes when the sample is cooled, as evidenced Fang and Mei [36].

The CCTO ceramics obtained mechanochemically showed great homogeneity in the distribution of particle size (100 nm and 500 nm) without any sintering effects. The X-ray EDS elemental analysis showed the presence of inclusions of zirconia or metallic iron (the results are not presented here).

Fig. 3. SEM images of CaCu$_3$Ti$_4$O$_{12}$: (a) and (b) from high-temperature treatment (CCTO/T), (c) and (d) from mechanochemical synthesis (CCTO/Zr) (two different magnifications).

3.3. Characteristics of dielectric properties of CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics

A dielectric relaxation phenomenon was used to describe the dielectric properties of the CCTO ceramics investigated at the temperature ranging from 473 K to 173 K. The experimental data were presented based on the electrical permittivity and electric modulus.

The electric modulus $M^* = M' + iM''$ and complex permittivity $\varepsilon^*$ formulae are related, i.e. $\varepsilon^* = 1/M^*$, and they are more thoroughly discussed elsewhere [37].

For the first time, this formula was used by Macedo et al. [38] who studied space-charge relaxation phenomena. From a physical point of view an electric modulus represents the real process of relaxation of an electrical field in the material when the electric displacement remains constant.

The formalism of electrical modulus is very sensitive to small changes in the value of capacitance, so it is among others the most suitable for the description of the electrical properties of grains in ceramic materials [39]. An additional advantage is the ability to separate intra-granular (bulk), inter-granular and electrode effects of sample.

Generally, the relaxation phenomena in the frequency ($\nu$) domain are characterized by the maximum dielectric loss $\varepsilon''(\nu)$ and the corresponding inflection point of curve dispersion $\varepsilon'(\nu)$.

A similar description of dielectric relaxation is represented in the case of an electrical modulus but the maximum $M''(\nu)$ is shifted to a higher frequency in respect of the $\varepsilon''(\nu)$ maximum [40].

Figures 4 and 5 show the temperature dependences of the imaginary component of $M''(T)$ and $\varepsilon''(T)$, respectively at the same frequency of electric field ($\nu = 1$ kHz) for all three samples obtained by different methods. A visualization of the temperature dependencies allows the initial estimation of the ranges of the occurrence of relaxations processes.
In the $M''(T)$ plot, at the temperature of above 350 K for CCTO/Zr and CCTO/T samples the maxima are visible that suggest the presence of relaxation processes. In contrast, on the $\varepsilon''(T)$ plot it can be seen a strong increase in the dielectric loss which is mainly connected with electrical conductivity. In turn, in the lower temperature region (below 200 K), the $M''(T)$ and $\varepsilon''(T)$ plots also display changes that indicate a relaxation in all investigated samples. However these processes have a different character and will be discussed on the basis of the frequency dependence of electrical modulus and electrical permittivity.

Figure 6 presents on the complex plane the electrical modulus $M''(M')$ at a temperature of 423 K for the three investigated ceramics. Only the experimental data for the CCTO/Fe sample show a semicircular arc which clearly indicates the relaxation process and enable to calculate the time of relaxation from the maximum of $M''(M')$ function.

The dependence of the components of electric permittivity at the temperature of 423 K on frequency are shown in Fig. 7. The largest dispersion of $\varepsilon'(\nu)$ is found in the CCTO/Fe sample. For the other two samples the value of $\varepsilon'(\nu)$ does not change very much, especially in the region below 1 kHz. The straight slopes were calculated for a log-log plot of $\varepsilon''(\nu)$ in low frequency range, and are between 0.80 and 0.95. These values, although close to those of dc conductivity (which has a straight slope of 1.0) suggest an extremely low frequency relaxation process which is connected to an electrical charge-carrier trapping.

In heterogeneous dielectric materials such as CCTO ceramics we can see phases with different electrical conductivities. The application of an electrical field to a sample causes the displacement of charge from the phases that are more conductive to those that are less. Especially in low frequency range a space charge and an interfacial polarization effects associated with it occur. This polarization results in the high values of $\varepsilon''(\nu)$ and dielectric losses $\varepsilon''(\nu)$. 

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**Fig. 4.** Temperature dependence of imaginary part of electrical modulus ($M''$) at 1 kHz for CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics.

**Fig. 5.** Temperature dependence of imaginary part of dielectric permittivity ($\varepsilon''$) at 1 kHz for CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics.

**Fig. 6.** Electrical modulus complex plane plots for CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics at 423 K. The inset shows an expanded view of frequency dependence of $M'$ and $M''$ (darker symbols) for CCTO/T and CCTO/Zr samples.
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Fig. 7. Frequency dependence of real ($\varepsilon'$) and imaginary ($\varepsilon''$) part of dielectric permittivity at 423 K for CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics.

Figure 7 presents the frequency dependence of the real and imaginary parts of the dielectric permittivity for CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics at 423 K.

Fig. 8. Electrical modulus complex plane plots for CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics at 173 K.

Figure 8 presents on the complex plane $M''(M')$ the experimental data obtained at the temperature of 173 K for all investigated ceramics. Graphs in a semicircular shape indicate the presence of relaxation processes. The centers of all these semicircles lie below the real axis $M'$. The degree of this lowering, which indicates the distribution of relaxation times, is the smallest for CCTO/Zr. For the CCTO/T sample the distribution of relaxation time continues to increase. It is vital to note that the graph is asymmetrical and greatly expanded, presumably it contains two superimposed semicircles. On the other hand for CCTO/Fe in the low-frequency range there is an additional semicircular arc. The centers of these arcs lie below the axis of the real component of the electric modulus.

The Cole-Cole plots at temperature of 173 K are presented in Fig. 9. A visual estimation of relaxation processes at approximately the same $\varepsilon''$ and $\varepsilon'$ scale for all ceramics is possible only for the CCTO/Zr sample. To scale up the $\varepsilon''(\varepsilon')$ graphs for the CCTO/T and CCTO/Fe samples, in the inset there were shown the frequency dependence characteristics of electric permittivity components. These characteristics provide more information on the topic of both dispersion and absorption phenomena in these materials. Normally, in the range of high frequencies an area of plateau of $\varepsilon'(\nu)$ is related to the permittivity of grains, but low-frequency dispersions correspond to a inter-grain or electrodes polarization [37]. Therefore, if the value of $\varepsilon'(\nu)$ lies outside of the area of the plateau the permittivity does not describe the intrinsic changes in the grains of the material.

For the investigated ceramics a perfect response was not obtained from the bulk material, meaning a flat, frequency-independent region. The decrease of $\varepsilon'(\nu)$ with increasing frequency, confirms the electrical inhomogeneity of the sample.

Figure 10 shows Arrhenius plots for the relaxation times described by the following equation: $\tau = \tau_0 \exp(-E_a/kT)$, where $\tau_0$ is the pre-exponential term, $E_a$ is the activation energy, and $k$ is the Boltzmann constant. The relaxation times $\tau$ for all investigated samples at the temperatures from the entire temperature range were determined from the spectrum of $M''(\nu)$. 
Fig. 10. Arrhenius plots of bulk (empty symbols) and grain boundary (filled symbols) relaxation times data for CaCu$_3$Ti$_4$O$_{12}$ (CCTO) ceramics.

<table>
<thead>
<tr>
<th>Composition</th>
<th>Temperature range [K]</th>
<th>Time relaxation range [s]</th>
<th>Activation energy [eV]</th>
<th>Pre-exponential term $\tau_0$ [s]</th>
</tr>
</thead>
<tbody>
<tr>
<td>CCTO/Zr</td>
<td>473 ± 353/8 × 10$^{-6}$ ± 6 × 10$^{-3}$</td>
<td>0.77/5.3 × 10$^{-14}$</td>
<td>0.40/6.4 × 10$^{-12}$</td>
<td></td>
</tr>
<tr>
<td>CCTO/T</td>
<td>213 ± 173/2 × 10$^{-7}$ ± 2 × 10$^{-6}$</td>
<td>0.83/1.0 × 10$^{-14}$</td>
<td>0.19/5.3 × 10$^{-12}$</td>
<td></td>
</tr>
<tr>
<td>CCTO/Fe</td>
<td>288 ± 173/2 × 10$^{-7}$ ± 3 × 10$^{-5}$</td>
<td>0.17/2.4 × 10$^{-11}$</td>
<td>0.19/8.7 × 10$^{-11}$</td>
<td></td>
</tr>
</tbody>
</table>

The pre-exponential term, $\tau_0$ was determined from equation $\ln \tau = \ln \tau_0 - E_a/kT$ assuming that $1/T \to 0$.

4. Final remarks and conclusions

The CaCu$_3$Ti$_4$O$_{12}$ ceramic powder was synthesized with the use of two different methods: via the mechanochemical synthesis at room temperature and by the high-temperature treatment of reagents. The properties of materials obtained by these two methods were compared, and the results showed that the time required for synthesis can be shortened when a thermal method is used from 12 h to between 1.5 and 5 h (dependent on milling energy).

For the first case, the effects of impurities introduced by the process of milling (ZrO$_2$ and Fe$^0$) on the physical and dielectrical properties are presented, as well as the methods by which such additives can be intentionally and rationally introduced for the optimization of the useful characteristics of the ceramic materials.

The microstructural tests of the differently-obtained materials demonstrate that the grain morphology and the number of present defects are important in determining various properties.

The results of dielectric property tests can be characterized as follows: in the frequency domain there are the different areas of dielectric relaxation. Practically across the entire temperature and frequency measurement range for all samples the values of dielectric permittivity and electrical modulus change. These changes contradict the general principle that the dielectric permittivity of CCTO is independent of frequency between 20 Hz and 1 MHz at room temperature. The activation energy related to different electro-active regions is determined on the basis of electrical modulus. At higher-temperature conditions (above 350 K), the relaxation processes are characteristic at the grain boundaries. The macroscopic Maxwell–Wagner–Sillars model of surface polarization, which describes this relaxation, probably refers to the heterogeneous distribution of oxygen atoms on the surface and in the interior of the sample. In turn, this distribution may be a result of the phase segregation of a Cu-rich layer on the surface of the sample. Below the temperature of 250 K and at a frequency of approximately 100 kHz, the dielectric relaxation is observed, similar to a relaxation of Debye-type. According to the IBLC model, this type of relaxation may be the surface polarization effects in both the grains on or in the grain boundaries.

Acknowledgments

This study was supported by the National Science Centre Poland, Project DEC-2012/05/N/ST8/03764 and by the Polish Ministry of Science and Higher Education DS/C-1/KWC/2014.
References


